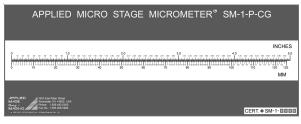
Stage Micrometers

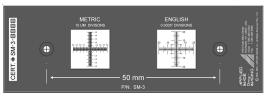
MICROSCOPY CALIBRATION STANDARDS



SM- 1 - **

Glass Size: 2" x 5.25" (50mm x 132mm) Scale Length: 5 inch (English) X-axis only 125mm (Metric) X-axis only

Divisions: English = 0.01" Metric = $100\mu m$ With numerical labeling every 1mm and 0.1 in.

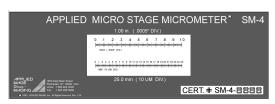


SM-3-**

Glass Size: 1" x 3" (25mm x 75mm) Scale Length: 0.40 inch (English) X & Y Axis

10.0 mm (Metric) X & Y axis

Divisions: English = 0.0005" Metric = $10\mu m$ With numerical scale labeling every 0.1mm and 0.05 in.



SM- 4 - **

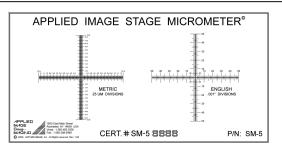
Glass Size: 1" x 3" (25mm x 75mm)
Scale Length: 1.0 inch (English) X-axis only

25mm (Metric) X-axis only

Divisions: English = 0.0005" Metric = $10\mu m$ With numerical scale labeling every 0.1mm and 0.05 in.

SM-5-**

1.5" x 3" (38mm x 75mm) 1.0 inch (English) X & Y axis 25mm (Metric) X & Y axis English = 0.001" Metric = 25μm With numerical scale labeling every 1mm and 0.1 in.



SM-6-**

1.5" x 3" (38mm x 75mm) 1.0 inch (English) X & Y axis 25mm (Metric) X & Y axis English = 0.0005" Metric = 10μm With numerical scale labeling every 0.1mm and 0.05 in.



SM- 12 - **

Glass Size: 1" x 3" (25mm x 75mm)
Scale Length: 0.08 inch (English) X-axis only
2.0mm (Metric) X-axis only

Divisions: English = 0.001" Metric = 25µm no numerical scale labeling

APPLIED MICRO STAGE MICROMETER® SM-13

ENGLISH METRIC

1 0.060 INCHES (0.0005* DIVISIONS)

METRIC
2 00MM (0.010 mm DIVISIONS)

CERT.# SM-13-BBB

SM- 13 - **

Glass Size: 1" x 3" (25mm x 75mm)
Scale Length: 0.08 inch (English) X & Y Axis
2.0mm (Metric) X & Y axis
Divisions: English = 0.001" Metric = 25μm
no numerical scale labeling

NOTE:

All SM, IAM and Accu-CAL SERIES Standards are available with Secondary or Direct NIST certification

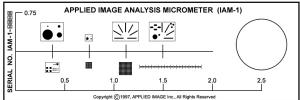
* insert desired substrate material code = CG (Chrome on Glass) or OP (OPal glass)

DATA OPTICS, INC. Image Analysis

VISION CALIBRATION STANDARDS

APPLIED IMAGE is proud to introduce the *IAM Series*, the first complete and true line of Image Analysis Microscopy Calibration Standards specifically designed to address the complex needs of today's generation of image analysis and machine vision systems. These unique standards are designed to test multiple morphometric parameters to assure that your image analysis system is working properly, meeting the required calibration / certification requirements of your vision measurement system.

Morphometric Image Analysis Standard Part No. IAM-1 **



Ideally suited for morphological calibration where two dimensional shapes have to be measured with accuracy. Composed of eight test plates of various shapes, positions, angles and sizes. We even included a linear measurement scale for calibrating your imaging system.

Overall size: 1" x 3" Image: positive image / chrome

Plate Frame Size Description
1 4600 x 3500 μ m CIRCLES - 2000, 1000, 500 & 250 μ m dia.
2 1000 x 800 μ m CIRCLES - 500, 250, 125 & 62.5 μ m dia.
3 1000 x 800 μ m BARS - 200 x 20 μ m at 30 degrees
4 1000 x 800 μ m Various shapes, circles, bars and angular designs

Plate Frame Size Description
5 1000 x 800 µm SQUARES - 100, 40, 20 µm set of 2 ea.
6 2050 x 1650 µm GRID PATTERNS - 50 µm open area and 50 µm line thickness
7 4200 x 3400 µm GRID PATTERNS - 200 µm open area and 200 µm line thickness
8 10,000 µm long Scale with 10 µm division

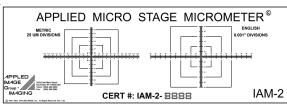


Test Plate No. 4

ASTM Grain Size / Nodularity Analysis Standard Part No. IAM-MET

Based on the Original IAM-1 Morphometric Image Analysis Standard above, the IAM-MET Grain / Nodularity standard is a multiple morphology calibration standard which was designed specifically for and by ASTM. The difference between the IAM-1 and IAM-MET is Plate No. 4. In the IAM-MET, test plate 4 has nine simulated images of irregular granular features most often found in metallurgical applications. In compliance with ASTM, the standard comes with Secondary Certification; Plate No. 8 (10,000 μm scale); and either Plate No. 1 (CIRCLES - 2000 μm, 1000 μm, 500 μm, 8 250 μm diameters); *or* No. 2 (CIRCLES - 500 μm, 250 μm, 125 μm, 8 62.5 μm dia.).

Linear (X & Y axis) Scale Part No. IAM-2 **



A dual axis linear micrometer that can accurately calibrate optical magnification, reticule scales and camera aspect ratio on a single standard for both axis without rotation. In addition, it can be used to calibrate and check linear stage motion or related auto measuring systems. Scales are in both English (inches) and Metric (millimeters) measurements.

Overall size: 1" x 3" Image: negative image / chrome

Scale Image: X = 1" (25mm) Y = 0.60" (15mm) Divisions: English = 0.001" Metric = 25 μ m

IAM-1 thru IAM-8

The IAM series is available on either glass for transmitted illumination applications, or opal for reflective illumination. When ordering, complete the part number with the following material code;

* * material code = CG (Chrome on Glass) or OP (Chrome on OPal glass)



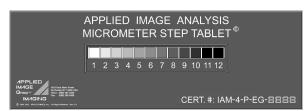
Ultra-High Resolution Target Part No. IAM-3 **



Based on the NIST/NBS 1010A and conforming to ANSI/ISO#2 standard, this target is ideal for verifying focus and resolution of high powered optical systems. With direct read information, the exact capabilities of the system will instantly be established. The values (in cycles per mm) are displayed next to 5 vertical and 5 horizontal evenly spaced bars, from 5.6 to 512 cycles per mm (89.2 μm to 0.98 μm bar sizes)

Overall size: 1" x 3" Image: negative image / chrome

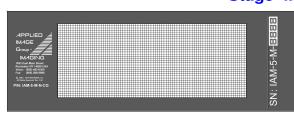
Neutral Density / Step Tablet Part No. IAM-4**



Designed for illumination and detection calibration, which is needed for today's exacting imaging & vision systems. This tablet has 12 transmission steps, nominally ranging from 0 to 100% transmission. The neutral density step tablet is ideal for testing linearity of the sensing system.

Overall size: 1" x 3" Image: positive image / emulsion

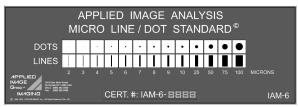
Stage Mapping / Grid Pattern Part No. IAM-5 **



The ideal standard for verifying / quantifying multiple image analysis parameters. Optical (barrel) distortion. Alignment between systems or optical paths. Cell areas for particle counting. The image area 20mm x 50mm. **Overall size**: 1" x 3"; image: negative image / Chrome Port No. Clear Aporture Operal Lines Pitch

<u>Part No.</u>	Clear Aperture	Opaque Lines	<u>Pitch</u>
IAM-5S	8.5μm sq .	1.5 µm	10 microns
IAM-5M	180μm sq.	20 μm	200 microns
IAM-5L	980µm sq.	20 µm	1000 microns

Micro Line / Dot Standard Part No. IAM-6**



A standard specifically designed to calibrate CCD, CMOS devices and other geometric measuring imaging systems where CRITICAL MEASUREMENT (CD's) is important. Electronic sensors often have spurious resolution created by pixel dithering. The IAM-6 limits this calibration problem by providing known dot and line sizes (2 μ m, 3 μ m, 4 μ m, 5 μ m, 6 μ m, 7 μ m, 8 μ m, 9 μ m, 10 μ m, 25 μ m, 50 μ m, 75 μ m, 100 μ m) to test the sensor / optical capability.

Overall size: 1" x 3" Image: positive image / chrome

Multi-Grid Standard Part No. IAM-8**



A uniquely designed standard with 4 different grid size patterns; 0.5 x 0.5mm grid with $25\mu m$ pitch; 1.0 x 1.0mm grid with $50\mu m$ pitch; 2.0 x 2.0mm grid with $100\mu m$ pitch; and 4.0 x 4.0mm grid with $200\mu m$ pitch. As well as a Star Target with 15 degree angle increments. This standard can be used to test not only the overall frame distortion issues but also linear distances for a wide variety of magnification ranges from 1x to 1000x power.

Overall size: 1" x 3" Image: positive image / chrome

APPLIED Basic IAM Calibration Kit Part No. IAM-100-KIT / **

Composed of the three basic **APPLIED** Image Analysis standards needed for calibrating any system; the Morphometric (IAM-1); the Linear Scale (IAM-2); and the Neutral Density / Step Tablet (IAM-4). The ideal calibration standards for the full service / discriminating lab.



Robotic Vision

CALIBRATION STANDARDS

ACCU-PLACE [™] Macro Calibration Standard



All Accu-Place Macro Calibration Standards have both X & Y axis metric scales. These dual axis standards are ideal for calibrating optical magnification, linear distance, stage motion as well as squareness of stage. In addition, with the larger area calibration scale, the calibration of low power optical systems over the longer distances can be easily carried out.

 Part No.
 AP-M200 / **
 AP-M300 / **

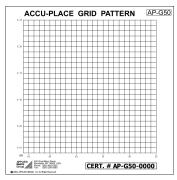
 Glass Size:
 250mm x 200mm
 350mm x 200mm

 Scale (X&Y):
 200mm x 150mm
 300mm x 150mm

 Divisions:
 Metric = 100 μm
 Metric = 200 μm

Pitch Accuracy: 2µm on Chrome on Glass or OPal glass

ACCU-PLACE[™] Grid Indexing Patterns



All Accu-Place Grid Indexing Pattern standards have number/letter indexed columns and rows for easy calibration of stage squareness, travel distance and motion. Ideally suited for image analysis as well as visual inspection systems where precise motion must be calibrated and measured.

 Part No.
 AP-G50 / * *
 AP-G100 / * *

 Part Size:
 100mm x 100mm
 125mm x 125mm

 Grid (X&Y):
 50mm x 50mm
 100mm x 100mm

 Pitch:
 Metric = 1.0mm
 Metric = 2.0mm

Part No.
Part Size:

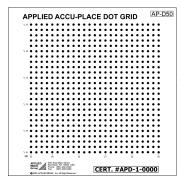
Grid (X&Y):
Pitch:

AP-G200 / * * AP-G300 / * *

250mm x 200mm 350mm x 200mm
350mm x 150mm
300mm x 150mm
Metric = 5.0mm
Metric = 10.0mm

Pitch Accuracy: 1µm on Chrome on Glass or OPal glass

ACCU-PLACE [™] Dot Patterns



All Accu-Place Dot Pattern standards have indexed columns and rows for ease of use. Ideally suited for checking / verifying / quantifying optical (barrel) distortion; alignment between optical systems (or paths); as well as calibrating optical instruments that have both a vision and motion system.

Metric = 10.0mm

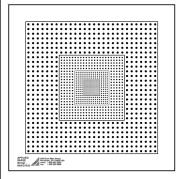
AP-D50 / * * AP-D100 / * * Part No. 100mm x 100mm 125mm x 125mm Part Size: Grid (X&Y): 50mm x 50mm 100mm x 100mm Pitch: Metric = 1.0mm Metric = 2.0mmDot Diameter: 0.1mm 0.2mm AP-D200 / * * AP-D300 / * * Part No. 250mm x 200mm 350mm x 200mm Part Size: Grid (X&Y): 200mm x 150mm 300mm x 150mm

Dot Diameter: 0.5mm 1.0mm

Pitch Accuracy: 1µm on Chrome on Glass or OPal glass

Metric = 5.0mm

ACCU-PLACE [™]Dot Distortion Target



The Accu-Place Dot Distortion target is designed for measuring distortion in an optical system. The precise amount of distortion is determined from an array of precisely placed dots in a regular array. Such measurements can be used to correct for any distortion that occurs within the optical system.

 Ist Zone:
 2.00 mm
 4.00 mm
 100mm x 100mm

 2nd Zone:
 1.00 mm
 2.00 mm
 50mm x 50mm

 3rd Zone:
 0.50 mm
 1.00 mm
 24mm x 24mm

 4th Zone:
 0.20 mm
 0.40 mm
 11.6mm x 11.6mm

Part No. AP-DD100 / * *
Part Size: 152mm x 152mm

Pitch Accuracy: 1µm on Chrome on Glass or OPal glass

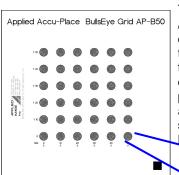
* * insert desired substrate material code

= CG (Chrome on Glass) = OP (OPal glass)

= TM (Transparent Material) = RM (Reflective Material)

Pitch:

ACCU-PLACE BullsEye /Recongnition Grid



The Accu-Place Bulls Eve / Recognition Grid is a unique concept in imaging calibration technology, designed with multiple series of circles within circles. This allows for multiple power magnification calibration as well as the testing of the system's ability to recognize and locate distinctive shapes within other shapes.

AP-B50 / * *

100mm x 100mm 50mm x 50mm Metric = 10mm 5mm

125mm x 125mm 100mm x 100mm Metric = 10mm 5_mm

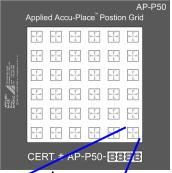
AP-B100 / *

AP-B200 / * * AP-B300 / * Part No. 250mm x 200mm 350mm x 200mm Part Size: Grid (X&Y): 200mm x 150mm 300mm x 150mm Pitch: Metric = 10mm Metric = 10mm

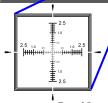
5_{mm}

Pitch Accuracy: 1µm on Chrome on Glass or OPal glass

ACCU-PLACE [™] Position Grid



The Accu-Place - Position Grid is a unique break through technology in testing POSITIONING and / or VISION recognition ability by having a matrix of small scales accurately positioned in a grid maxtrix format. The scales have a pitch accuracy of 1µm when produced on either Chrome on Glass or Chrome on Opal Glass.



AP-P50 / * * 100mm x 100mm 50mm x 50mm

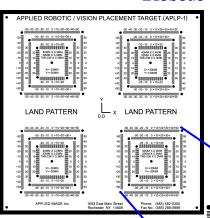
AP-P100 / * * 125mm x 125mm 100mm x 100mm Metric = 10mm Metric = 10mm 5mm 5mm

AP-P200 / * * AP-P300 / * * Part No. 250mm x 200mm 350mm x 200mm Part Size: Grid (X&Y): 200mm x 150mm 300mm x 150mm Metric = 10mm Metric = 10mm Pitch: Scale Overall Size: 5_mm 5mm

Pitch Accuracy: 1µm on Chrome on Glass or OPal glass

Robotic ACCU-PLACE [™] Pick and Place System

5_{mm}



Circle Overall Size:

APPLIED IMAGE Group / IMAGING in conjunction with Hewlett Packard Corporation has developed a unique, and extremely accurate, PICK & PLACE target set designed to check for accuracy and repeatability of your robotic system, quick and easy.

The target set consists of a receiver grid (LAND PATTERN) and the parts to be picked (COMPONENTS). The component part is picked by the robotic system and placed onto the land pattern at which point Robotic / Vision position placement can be easily measured using the intergrated scales which are built into the target land pattern design.

The APPLIED ACCU - PLACE Pick & Place Calibration System target addresses the important issues of the robotic "pick and place" testing in an inexpensive mode. The test set comes complete with full instructions.

The Land Pattern and all of the Test Components can be calibrated and certified to N.I.S.T. traceable standards. In addition, APPLIED offers Anti-Reflective coatings (AR) on all components.

> The patterns can also be customized for two sided systems or on reflective materials where reflection images are a necessity (instead of transmission).

PLACEMENT ACCURACY

Direct Read to 5 microns in the X. Y and theta positions

$f ACCU ext{-}f PLACE f L$ and f Pattern Plate

APLP-1 Standard ACCU-PLACE Land Pattern plate consists of the following grids/scales:

40 mm x 0.5 mm pitch 32 mm x 0.5 mm pitch 40 mm x 0.4 mm pitch 32 mm x 0.4 mm pitch 32 mm x 0.3 mm pitch 40 mm x 0.3 mm pitch TAB 236 x 0.3 mm (pitch)

ACCU-PLACE Test Components

Available components sizes:

APTC-4 32mm x 0.5mm pitch APTC-1 40mm x 0.5mm pitch APTC-5 32mm x 0.4mm pitch APTC-2 40mm x 0.4mm pitch APTC-3 40mm x 0.3mm pitch APTC-6 32mm x 0.3mm pitch

APTC-7 TAB 236 x 0.3mm pitch

ACCU-PLACE Land Pattern Kit

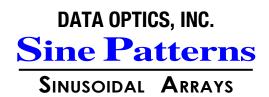
APKIT-1 APPLIED IMAGE ACCU - PLACE Land Pattern Kit. Consisting of one each of the following:

40MM X 0.39MM

APPLIED IMAGE. Inc

APLP-1 Standard ACCU - PLACE Land pattern plate APTC-1 40mm x 0.5mm pitch APTC-2 40mm x 0.4mm pitch APTC-3 40mm x 0.3mm pitch APTC-4 32mm x 0.5mm pitch APTC-5 32mm x 0.4mm pitch

> APTC-6 32mm x 0.3mm pitch APTC-7 TAB 236 x 0.3 mm pitch



SINUSOIDAL TARGETS & ARRAYS

Over twenty years ago, Dr. Robert Lambert founded \$INE Patterns on a single concept - to provide a new and better test array pattern for optical evaluations. After extensive research, Dr. Lambert developed the first sinusoidal target array pattern, for which he later received a US Patent. Since then, \$INE Patterns has expanded its product line to provide sinusoidal target arrays for a variety of applications; from moiré contouring to reliable MTF evaluation of materials, lenses, cameras, and electrooptical systems.

Today, SINE sinusoidal target arrays are available exclusively from APPLIED IMAGE on transmission film or on reflective materials as well as in a variety of sizes and frequencies.

The reflection sinusoidal pattern arrays are made on reflective materials. They have proven to be very useful for MTF evaluation of various types of cameras and scanners. Because of the inherent limitations of reflective materials, the maximum spatial frequency of the reflective pattern arrays is limited to 20 cycles per mm.



SINUSOIDAL VISION DEMONSTRATION ARRAY

The Sinusoidal Visual Demonstration Array is designed to demonstrate the Modulation Transfer Function (MTF) of the human eye. Its transmittance varies sinusoidally and increases in spatial frequency from 0.2 to 20 c/mm, following a logrithmic scale. The modulation increases linearly from top to bottom. One can see, in the image, where the visual contrast contour disappears which is the MTF of the eye.

Ideally suited for teaching and demonstration - the SINE Sinusoidal Visual Demonstration Array is now available on either RM - Reflective Material (photo paper) or TM Transmission Material (film), mounted between glass or directly mounted in a glass 2" x 2" projection slide.

The SINE Reflective Sinusoidal Visual Demonstration Array on Reflective Material (photo paper);

Image size: 10 inch x 10 inch Part No. SINE LSR-1-RM

The SINE Transmission Sinusoidal Visual Demonstration Array on Transmission Material (film) mounted between glass; Image size: 2 inch x 2 inch

Part No. SINE LSM-1-TM-G

The SINE Transmission Sinusoidal Visual Demonstration Array on Transmission Material (film) mounted into a 2 inch x 2 inch projection slide Image size: 1.8 inch x 1.8 inch Part No. SINE LSM-1-TM-SL



SINUSOIDAL ARRAY SINE M-13-60-S-RM for Fingerprint Conformance to IAFIS Requirements

The Newest Sinusoidal Array, SINE M-13-60-S-RM, was designed jointly by the Federal Bureau of Investigation, in Washington DC, and MITRE, of Bedford MA. The primary function of this new target is for computing Modulation Transfer Function (MTF) evaluation in live scanner fingerprint systems for conformance to Integrated Automated Fingerprint Identification Systems (IAFIS) image quality requirements. The array is on reflective material measuring 16mm by 16mm with sinusoidal arrays ranging in frequency from 1.0 to 10.0 cycles per mm; with nominal modulation of the sinusoidal areas at 60%. The top and bottom rows are density scales, from 0.20 to 1.20 densities.

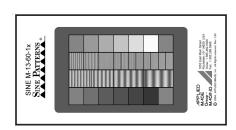
The SINE Reflective Sinusoidal Array for Fingerprint Conformance to IADIS Requirements on Reflective Material (photo paper); Image size: 16mm x 16mm

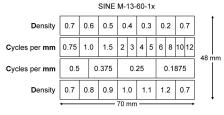
SINE M13-60-S-RM Part No.

DATA OPTICS, INC. Sine Patterns

SINUSOIDAL REFLECTIVE ARRAYS

SINUSOIDAL ARRAY SINE M-13-60





The **Sinusoidal Array SINE M-13-60** is designed to be used for evaluating systems that work in the reflective mode such as scanners, machine vision systems, and cameras. It is supplied in five different sizes. The map shown is the 1X version. The $\frac{1}{2}X$ and 1X slides incorporate the same spatial frequencies. Spatial frequencies for the 2X, 4X, and 8X versions are $\frac{1}{2}$, $\frac{1}{4}$ and $\frac{1}{8}$ respectively.

The upper and lower rows, in each test pattern array, contain the gray scales and the numbers in the boxes indicate their approximate reflection density. The four corner areas are 0.7 density, all within 0.02 density, which are useful for checking uniformity of illumination. The inner rows contain the sinusoidal areas, having the indicated spatial frequencies noted on the map. Nominal modulation of the sinusoidal areas is 60%.

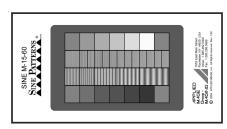
Each pattern array is supplied with a digital microdensitometer scan that lists the individual modulation values and density values of the gray scales. Modulation values are also given with compensation for the MTF of the microdensitometer.

The SINE M-13-60-1X pattern array is available in kit form with a 1.0 c/mm Ronchi Ruling standard as specified by the Federal Bureau of Investigation (FBI) specification for performance testing of fingerprint scanners. Software is available for use of this pattern to evaluate scanners. There is no charge for this software. (See also the FBI SIQT Scanner Test Chart).

Part No.	SINE M-13-60-1/2X-RM	SINE M-13-60-1X-RM	SINE M-13-60-2X-RM	SINE M-13-60-4X-RM	SINE M-13-60-8X-RM
Image Area	35mm x 23mm	70mm x 46mm	140mm x 92mm	280mm x 186mm	560mm x 372mm
Type	Reflective	Reflective	Reflective	Reflective	Reflective
Modulation	60%	60%	60%	60%	60%

- Catalog Numbering for Ordering Sinusoidal Array SINE M13-60: SINE M-13 (basic array configuration) 60 (percent modulation) [array magnification]X RM (Reflective Material)
- A digital microdensitometer scan is included with all Sinusoidal gratings.

SINUSOIDAL ARRAY SINE M-15-60





The reflective **Sinusoidal Array SINE M-15-60** is similar to the M-13-60 (1X version) except that the range of spatial frequencies begins with 0.2 cycles per mm and extends to 20 cycles per mm.

The outer two rows contain the gray scales and the numbers in the boxes in the diagram indicate their nominal density values. The two inner rows contain the sinusoidal areas and the numbers indicate the spatial frequencies in cycles per mm.

A digital microdensitometer scan is included with each pattern array. Modulation values are also given with compensation for the MTF of the microdensitometer.

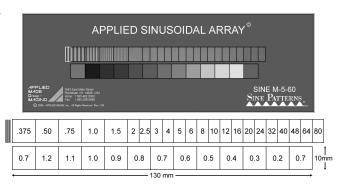
Part No.	SINE M-15-60-RM
Image Area	70mm x 48mm
Type	Reflective
Modulation	60%

DATA OPTICS, INC. Sine Patterns

SINUSOIDAL TRANSMISSION ARRAYS

The transmission SINE Patterns sinusoidal target arrays are made on extremely high resolution films. This makes it possible to achieve spatial frequencies as high as 256 cycles per mm. Most of SINE sinusoidal target transmission array patterns are available with modulation (contrast) values of 35%, 60% or 80%. Harmonic distortion the sinusoidal target array patterns are generally less than 3%.

SINUSOIDAL ARRAY SINE M-5



The Sinusoidal Array **SINE M-5** is made on a strip of 70mm film approximately 8.5 inches (215mm) in length.

The upper row, as shown in the diagram, contains the sinusoidal areas with the spatial frequencies in cycles per mm. All sinusoidal areas are carefully oriented with respect to the others, and the lines at the left end of the array have been added for alignment purposes.

A gray scale is in the lower row and the numerals show the approximate density values. For the 80% modulation pattern the gray scales steps increase approximately 0.12% in size, in order that the scale exceeds the range of the sinusoidal areas.

A digital microdensitometer scan is included with each test target.

	Transmission Material							
Part No.	SINE M-5-35-TM	SINE M-5-60-TM	SINE M-5-80-TM					
Image Area	130mm x 21mm	130mm x 21mm	130mm x 21mm					
Type	Transmission	Transmission	Transmission					
Modulation	35%	60%	80%					

Transmission Material - Mounted between Glass						
SINE M-5-35-G	SINE M-5-60-G	SINE M-5-80-G				
130mm x 21mm	130mm x 21mm	130mm x 21mm				
Transmission	Transmission	Transmission				
35%	60%	80%				

APPLIED SINUSOIDAL ARRAY 0.2 0.6 Density 0.7 0.3 0.4 0.5 0.7 6 5 Cycle per mm 46 mm Cycle per mm 1.0 1.5 2 2.5 3 0.9 0.8 0.7 Density 1.0 70 mm

SINUSOIDAL ARRAY SINE M-6

The Sinusoidal Array **SINE M-6** contains the same gray scales and sinusoidal areas as the M-5 but is arranged in a shorter and wider format, making it particularly useful when the complete array is to be imaged at one time.

The overall size of the array is 46mm x 70mm; centered on an 8.5 inch (215mm) strip of 70mm film.

A digital microdensitometer scan is included with each test target.

	Tra	Transmission Material						
Part No.	SINE M-6-35-TM	SINE M-6-60-TM	SINE M-6-80-TM					
Image Area	70mm x 46mm	70mm x 46mm	70mm x 46mm					
Type	Transmission	Transmission	Transmission					
Modulation	35%	60%	80%					

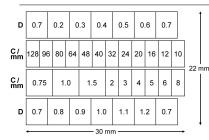
Transmission Material - Mounted between Glass						
SINE M-6-35-G	SINE M-6-80-G					
70mm x 46mm	70mm x 46mm	70mm x 46mm				
Transmission	Transmission	Transmission				
35%	60%	80%				

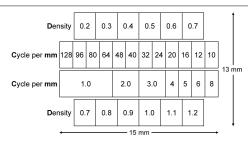
SINE M-14

APPLIED SINUSOIDAL ARRAY

SINE M-19







D er	nsity	0.	2	0.3	().4	0.	5	0.6	0	.7			
Cycle per mm	256	192	160	128	96	80	64	48	40	32	24	20	6.31	
Cycle per mm		2	2			4	•	3	8	10	12	16	0.51	
D er	sity	0.	7	0.8	().9	1.0	0	1.1	1	.2			
	-					7.5	mm ·					—		

The Sinusoidal Array SINE M-7 has an overall size of 22mm x 30mm which makes it small enough to fit into a standard 35mm projection frame. The gray scale is contained in the outer rows. It is made on 35mm perforated film. Also available, as a custom item, on a wider film (without perforations) cemented between glass.

The Sinusoidal Array SINE M-14 was designed for various electro-optical applications, particularly where a small array is needed to fit into the frame. It can fit into an 18mm diameter circle or into a standard 35mm motion picture frame.

The lines in the **SINE M-14** lie perpendicular to the length of the film. In addition the pattern is available on a wider film (without perforations) cemented between glass.

The Sinusoidal Array SINE M-19 is a remarkable new test array that achieves 256 cycles per mm while maintaining a significant modulation. It is designed for testing high resolution optical systems such as microscopes. Because its maximum width is 7.5mm, the SINE M-19 is small enough to fit easily onto a standard microscope slide. A 1" x 3" micro-slide, with cover slip, is an available mounting option.

	Tra	ansmission Mater	rial	Transmission	Material - Mounte	d between Glass
Array	35% Modulation	60% Modulation	80% Modulation	35% Modulation	60% Modulation	80% Modulation
SINE M-7	SINE M-7-35-TM	SINE M- 7-60-TM	SINE M- 7-80-TM	SINE M-7-35-G	SINE M- 7-60-G	SINE M- 7-80-G
SINE M-14	N/A	SINE M-14-60-TM	SINE M-14-80-TM	N/A	SINE M-14-60-G	SINE M-14-80-G
SINE M-19	N/A	N/A	SINE M-19-80-TM	N/A	N/A	SINE M-19-80-G

SINUSOIDAL SINGLE FREQUENCY GRATINGS

The Single Frequency Transmission Arrays have proven to be very useful for specialized MTF measurements as well as for applications such as moire contouring.

The modulation values for the harmonics are generally 2% or less. Minimum densities are approximately 0.2 and the average transmittance is about 30%.

Reflective single frequency arrays can also be custom produced for lower spatial frequencies.

		Transmission Material						
Freq	uency	80% Modulation	90% Modulation					
0.1	c/mm	SF-0.1-80-TM	SF-0.1-90-TM					
0.2	c/mm	SF-0.2-80-TM	SF-0.2-90-TM					
0.5	c/mm	SF-0.5-80-TM	SF-0.5-90-TM					
1.0	c/mm	SF-1.0-80-TM	SF-1.0-90-TM					
1.5	c/mm	SF-1.5-80-TM	SF-1.5-90-TM					
2.0	c/mm	SF-2.0-80-TM	SF-2.0-90-TM					
2.5	c/mm	SF-2.5-80-TM	SF-2.5-90-TM					
3.0	c/mm	SF-3.0-80-TM	SF-3.0-90-TM					
4.0	c/mm	SF-4.0-80-TM	SF-4.0-90-TM					
5.0	c/mm	SF-5.0-80-TM	SF-5.0-90-TM					
6.0	c/mm	SF-6.0-80-TM	N/A					
8.0	c/mm	SF-8.0-80-TM	N/A					
10.0	c/mm	SF-10.0-80-TM	N/A					
12.0	c/mm	SF-12.0-80-TM	N/A					
16.0	c/mm	SF-16.0-80-TM	N/A					
20.0	c/mm	SF-20.0-80-TM	N/A					
24.0	c/mm	SF-24.0-80-TM	N/A					

Mounted between Glass						
80% Modulation	90% Modulation					
SF-0.1-80-G	SF-0.1-90-G					
SF-0.2-80-G	SF-0.2-90-G					
SF-0.5-80-G	SF-0.5-90-G					
SF-1.0-80-G	SF-1.0-90-G					
SF-1.5-80-G	SF-1.5-90-G					
SF-2.0-80-G	SF-2.0-90-G					
SF-2.5-80-G	SF-2.5-90-G					
SF-3.0-80-G	SF-3.0-90-G					
SF-4.0-80-G	SF-4.0-90-G					
SF-5.0-80-G	SF-5.0-90-G					
SF-6.0-80-G	N/A					
SF-8.0-80-G	N/A					
SF-10.0-80-G	N/A					
SF-12.0-80-G	N/A					
SF-16.0-80-G	N/A					
SF-20.0-80-G	N/A					
SF-24.0-80-G	N/A					

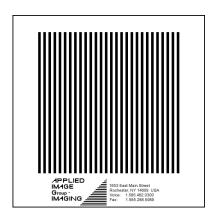
- Catalog Number for Ordering Sinusoidal Single Frequency Gratings:

SF - [frequency/mm]G - [percent - modulation] - [material] - (suffix "G" for Mounted in Glass) Ex: SF-0.2-80-TM
SF = Single Frequency - 0.2G = frequency grating - 80 = percent modulation -TM = Transparent Material (film, photo)
[add the suffix "- G" = for Mounted between Glass]

A digital microdensitometer scan is included with all Sinusoidal gratings.

Ronchi Rulings

and GRATINGS



APPLIED IMAGE precision **RONCHI RULINGS** are generated using our unique semi-conductor pattern-generators. The result is an extremely accurate ronchi pattern with smooth line edges and square edge profile.

Other optical-grade substrate materials (such as Quartz, Silicon, Alumina, etc.) as well as other frequencies (cycle/mm) are available upon request. In addition all substrates material can be machined to your specific size and requirements.

English RONCHI RULINGS are also available. Contact **APPLIED IMAGE** for the complete list.

Tr	Transparent Material Reflective Material						
Image Area:	4 inch x 4 inch	4 inch x 4 inch					
Overall Size:	5 inch x 5 inch	5 inch x 5 inch					
0.5 c/mm	RR0.5-N-TM	RR0.5-N-RM					
1.0 c/mm	RR1-N-TM	RR1-N-RM					
2.0 c/mm	RR2-N-TM	RR2-N-RM					
2.5 c/mm	RR2.5-N-TM	RR2.5-N-RM					
3.0 c/mm	RR3-N-TM	RR3-N-RM					
4.0 c/mm	RR4-N-TM	RR4-N-RM					
5.0 c/mm	RR5-N-TM	RR5-N-RM					
10.0 c/mm	RR10-N-TM	RR10-N-RM					
20.0 c/mm	RR20-N-TM	N/A					
30.0 c/mm	RR30-N-TM	N/A					
40.0 c/mm	RR40-N-TM	N/A					
50.0 c/mm	RR50-N-TM	N/A					

	——— Chrome on Glass ———						
Image Area:	1 inch x 1 inch	2 inch x 2 inch	4 inch x 4 inch				
Overall Size:	2.5 inch x 2.5 inch	4 inch x 4 inch	5 inch x 5 inch				
0.5 c/mm	RR0.5-12-CG	RR0.5-24-CG	RR0.5-45-CG				
1.0 c/mm	RR1-12-CG	RR1-24-CG	RR1-45-CG				
2.0 c/mm	RR2-12-CG	RR2-24-CG	RR2-45-CG				
2.5 c/mm	RR2.5-12-CG	RR2.5-24-CG	RR2.5-45-CG				
3.0 c/mm	RR3-12-CG	RR3-24-CG	RR3-45-CG				
4.0 c/mm	RR4-12-CG	RR4-24-CG	RR4-45-CG				
5.0 c/mm	RR5-12-CG	RR5-24-CG	RR5-45-CG				
10.0 c/mm	RR10-12-CG	RR10-24-CG	RR10-45-CG				
20.0 c/mm	RR20-12-CG	RR20-24-CG	RR20-45-CG				
30.0 c/mm	RR30-12-CG	RR30-24-CG	RR30-45-CG				
40.0 c/mm	RR40-12-CG	RR40-24-CG	RR40-45-CG				
50.0 c/mm	RR50-12-CG	RR50-24-CG	RR50-45-CG				
100.0 c/mm	RR100-12-CG	RR100-24-CG	RR100-45-CG				
150.0 c/mm	RR150-12-CG	RR150-24-CG	RR150-45-CG				
200.0 c/mm	RR200-12-CG	RR200-24-CG	RR200-45-CG				
250.0 c/mm	RR250-12-CG	RR250-24-CG	RR250-45-CG				
300.0 c/mm	RR300-12-CG	RR300-24-CG	RR300-45-CG				
400.0 c/mm	RR400-12-CG	RR400-24-CG	RR400-45-CG				
500.0 c/mm	RR500-12-CG	RR500-24-CG	RR500-45-CG				

		OP al glass	
Image Area:	1 inch x 1 inch	2 inch x 2 inch	4 inch x 4 inch
Overall Size:	2.5 inch x 2.5 inch	4 inch x 4 inch	5 inch x 5 inch
0.5 c/mm	RR0.5-12-OP	RR0.5-24-OP	RR0.5-45-OP
1.0 c/mm	RR1-12-OP	RR1-24-OP	RR1-45-OP
2.0 c/mm	RR2-12-OP	RR2-24-OP	RR2-45-OP
2.5 c/mm	RR2.5-12-OP	RR2.5-24-OP	RR2.5-45-OP
3.0 c/mm	RR3-12-OP	RR3-24-OP	RR3-45-OP
4.0 c/mm	RR4-12-OP	RR4-24-OP	RR4-45-OP
5.0 c/mm	RR5-12-OP	RR5-24-OP	RR5-45-OP
10.0 c/mm	RR10-12-OP	RR10-24-OP	RR10-45-OP
20.0 c/mm	RR20-12-OP	RR20-24-OP	RR20-45-OP
30.0 c/mm	RR30-12-OP	RR30-24-OP	RR30-45-OP
40.0 c/mm	RR40-12-OP	RR40-24-OP	RR40-45-OP
50.0 c/mm	RR50-12-OP	RR50-24-OP	RR50-45-OP
100.0 c/mm	RR100-12-OP	RR100-24-OP	RR100-45-OP
150.0 c/mm	RR150-12-OP	RR150-24-OP	RR150-45-OP
200.0 c/mm	RR200-12-OP	RR200-25-OP	RR200-45-OP
250.0 c/mm	RR250-12-OP	RR250-25-OP	RR250-45-OP
300.0 c/mm	RR300-12-OP	RR300-25-OP	RR300-45-OP
400.0 c/mm	RR400-12-OP	RR400-25-OP	RR400-45-OP
500.0 c/mm	RR500-12-OP	RR500-25-OP	RR500-45-OP

Catalog Number for Ordering Ronchi Rulings: RR - [cycle/mm] - [size] - [polarity] - [material]

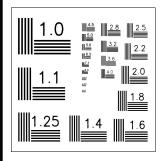
Ex: RR-2.5-12-N-CG: RR = ronchi ruling 2.5 = cycle/mm 12 = size N = polarity CG = Substrate Material

Substrate Material CG = Chrome on Glass OP = OPal glass

RM = Reflective Material (paper, photo) TM = Transparent Material (film, photo)

Test Targets

OPTICAL / IMAGING / RESOLUTION



Overall Size: 102mm x 102mm

 $||| \equiv 1$

||| **=** 3 ||| **=** 4

T-10

MICROCOPY TEST TARGET

Data: Conforms to NIST/NBS 1010A, & ANSI/ISO test chart #2; frequency shown in cycles per mm and changes by an average of 12.2% per step; image overall 38mm x 45mm.

Notes: Read direct resolution; ideal for evaluation of Optical / Mechanical Systems where reduction and low resolution is of interest.

	Cycles/mm	Polarity C	Chrome on Glass	OPal glass	Trans. Material	Refl. Material
T-10	1 - 18 c/mm	Positive	T-10-P-CG	T-10-P-OP	T-10-P-TM	T-10-P-RM
		Negative	T-10-N-CG	T-10-N-OP	T-10-N-TM	T-10-N-RM
T-10-1	1 - 180 c/mm	Positive	T-10-1-P-CG	T-10-1-P-OP	T-10-1-P-TM	
		Negative	T-10-1-N-CG	T-10-1-N-OP	T-10-1-N-TM	
T-10-2	1 - 512 c/mm	Negative	T-10-2-N-CG			

T-20

USAF 1951 TEST TARGET

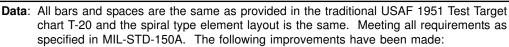
Data: Designed to MIL-STD-150A; frequency changes by $6\sqrt{2}$ progression; image overall 71mm x 58mm; also available in custom sizes and contrasts. Ideally suited for Imaging materials, Visual resolution or Optical systems.

Overall Size: T-20 **T-20-2** 102mm x 102mm 102mm x 102mm **T-20-M** 305mm x 305mm **T-20-L** 965mm x 1016mm

	Cycles/mm	Polarity (Chrome on Glass	OPal glass	Trans. Material to 181 c/mm	Refl. Material to 22.64 c/mm
T-20	0.25 - 228	Positive	T-20-P-CG	T-20-P-OP	T-20-P-TM	T-20-P-RM
		Negative	T-20-N-CG	T-20-N-OP	T-20-N-TM	T-20-N-RM
T-20-2	0.25 - 512	Negative	T-20-2-N-CG			

T-20-M-P-RM **T-20-M** 0.0625 - 3.56 Positive **T-20-L** .015625 - 3.56 Positive T-20-L-P-RM

USAF 1951 TEST TARGET - with IMPROVED LABELING



- The chart has **DIRECT frequency Labeling in C/MM**. Thus, no cross reference documentation is required to determine frequencies.
- Numeric labeling is enhanced and based on OCR-A extended font, to maximize recognizability.

Overall Size: **T-21** 102mm x 102mm **T-21-2** 102mm x 102mm

	Cycles/mm	Polarity (Chrome on Glass	OPal glass	Trans. Material to 181 c/mm	Refl. Material to 22.64 c/mm
T-21	0.25 - 228	Positive	T-21-P-CG	T-21-P-OP	T-21-P-TM	T-21-P-RM
T 21 2	0.25 512	Magativa	T 21 2 N CC			

T-21-2 0.25 - 512 Negative **T-21-2-N-CG**

T-21 / USAF-1951 abeled in cycles per mm requirements of Mil-Std-150A) **| ||| =**0.50 III **=** 0 ⋅ 5 b III **≡**0.63 **=**0.25 D·45**≡ |||**

T-22

T-22-2

0.25 - 512

USAF 1951 TEST TARGET - with IMPROVED LAYOUT and FEATURES

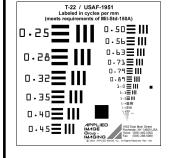
Data: All bars and spaces are the same as provided in the traditional USAF 1951 Test Target chart T-20; Meeting all requirements as specified in MIL-STD-150A. The following improvements have been made:

- The chart has DIRECT frequency Labeling in C/MM.

Negative T-22-2-N-CG

- Numeric labeling is enhanced and based on OCR-A extended font.
- Bars are laid out in two straight columns, for easier scanning.
- Smaller elements have finder squares next to them to aid in determining their locations.

Overall Size: **T-22** 102mm x 102mm **T-22-2** 102mm x 102mm Refl. Material to 22.64 c/mm Trans. Material Cycles/mm Polarity Chrome on Glass OPal glass to 181 c/mm 0.25 - 228 **T-22-P-CG** T-22-P-OP T-22-P-RM T-22 Positive T-22-P-TM



T-30 RIT ALPHANUMERIC CHART

Data: Alphanumeric configuration with frequency range 1-18 cycles/mm in 25 groups. Image overall 50mm x 50mm divided into 4 quadrants. Available in custom sizes and contrasts as well.

Notes: Especially useful in Optical / Visual evaluation or where cross consistency among users is important.

	Cycles/mm	Polarity (Chrome on Glass	OPal glass	T <u>rans. Materia</u> l	Refl. Material
T-30	1 - 18c/mm	Positive	T-30-P-CG	T-30-P-OP	T-30-P-TM	T-30-P-RM
		Negative	T-30-N-CG	T-30-N-OP	T-30-N-TM	T-30-N-RM

T-40

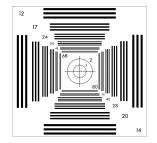
NBS-1952 RESOLUTION TEST CHART

Data: The NBS-1952 Resolution Test Chart is described in the NBS circular 533-1953 in the section "Method of Determining the Resolution Power of Photographic Lenses". Design features of this target reduce edge effects, minimize spurious resolution and permit one pass scanning.

Notes: The NBS method of using this chart to test lenses involves placing the chart at a distance from the lens equal to 26 times the focal length of the lens, resulting in a 25x reduction. The reduction effective cycles per mm is 12 to 80 c/mm.

	Cycles/mm	Polarity	Chrome on Glass	OPal glass	Trans. Material	Refl. Material
T-40-1	0.48 - 3.2	Positive	T-40-1-P-CG	T-40-1-P-OP	T-40-1-P-TM	T-40-1-P-RM

SAYCE TARGET



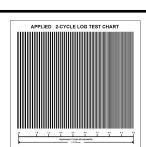
Overall Size: 100mm x 100mm

T-60

Data: Frequency range in c/mm (20:1 range). Other frequencies available on request.

Notes: Each bar and space is progressively smaller in a log manner. Peaked groups every 10 bars; ideally suited for microdensitometric scanning. Other reduction ranges, contrasts and material are available.

	Overall	Size:	T-60-1	150mm	x 150mm	T-60-	2 25mm x 75m	m T-60-3 25	5mm x 75mm
		Cycles	<u>s/mm</u>	Polarity	Chrome on	Glass	OPal glass	Trans. Material	Refl. Material
	T-60-1	0.25 -	- 5	Positive	T-60-1-P-	-CG	T-60-1-P-OP	T-60-1-P-TM	T-60-1-P-RM
ı	T-60-2	2.50 -	- 50	Positive	T-60-2-P	-CG	T-60-2-P-OP	T-60-2-P-TM	
ı	T 60 2	25.0	500	Docitivo	T_60_3_P	-CC	T 60 3 D OD		

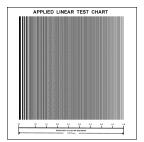


T-61 2-CYCLE LOG TARGET

Data: Frequency range 0.25 to 5c/mm and 2.50 to 50 c/mm. Other frequencies and sizes are available on request.

Notes: Equivalent cycles increase logarithmically; with two full cycles in each range. Ideally suited for scanning and micro densitometry. Each group of 2 bars and 2 spaces is progressively smaller in size.

Overall	Size:	1-01-1	130mm	1 X 130mm 1-6	1-2 25mm x /5n	nm	
	Cycles/	mm_	Polarity	Chrome on Glass	OPal glass	Trans. Material	Refl. Material
T-61-1	0.25 -	5	Positive	T-61-1-P-CG	T-61-1-P-OP	T-61-1-P-TM	T-61-1-P-RM
T-61-2	2.50 -	50	Positive	T-61-2-P-CG	T-61-2-P-OP	T-61-2-P-TM	
T-61-3	2.50 -	500	Positive	T-61-3-P-CG	T-61-3-P-OP		



T-62 LINEAR TARGET

Positive

Data: Frequency range 0.25 to 5c/mm; 2.50 to 50 c/mm; and 25 to 500c/mm. Other frequencies and sizes are available on request.

Notes: Lines and spaces for which the equivalent cycles per mm increases as the function of linear position; with each bar and space progressively smaller size, by linear change of the c/mm value. Ideally suited for sensing & scanning equipment.

Overall	Size:	T-62-1	150mm	x 150mm T-6 2	2-2 25mm x 75r	nm	
	Cycles	<u>/mm</u>	Polarity	Chrome on Glass	OPal glass	Trans. Material	Refl. Material
T-62-1	0.25 -	- 5	Positive	T-62-1-P-CG	T-62-1-P-OP	T-62-1-P-TM	T-62-1-P-RM
T-62-2	2.50 -	- 50	Positive	T-62-2-P-CG	T-62-2-P-OP	T-62-2-P-TM	

T-62-3-P-CG

T-62-3 25.0 - 500

T-62-3-P-OP

Overall Size: 100mm x 100mm

T-50

STAR SECTOR TARGET

Wedge shaped segments with 45 equal bar and space widths (8 degrees per cycle or 4 Data: degrees per spoke) over a 360 degree circumference circle. Overall image size 50mm diameter.

Notes: An ideal target for detecting Optical Astigmatism, Focus Errors and other aberrations. Can easily be incorporated into complete target arrays.

Cycles/mm Polarity Chrome on Glass OPal glass Trans. Material Refl. Material T-50-1 0.29 - 20T-50-1-P-RM Positive

T-50-2 0.29 - 100 T-50-2-P-CG T-50-2-N-OP T-50-2-P-TM



Overall Size: 50mm x 50mm

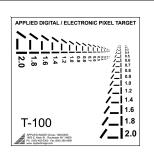
T-90

ULTRA HIGH RESOLUTION TARGET

Data: Frequency range from 1 c/mm to 500 c/mm; 100:1 or greater contrast; Bar width to length ratio 1:10; chrome image area on glass substrate.

Notes: The bar pattern gives direct limit of cut-off resolution. Ideal for microdensitometer scanning, hi-power optical systems, semi-conductor processing and CCD devices.

	Cycles/mm	<u>Polarity</u>	Chrome on Glass	OPal glass	Trans. Material	Refl. Material
T-90	1 - 500c/mm	Negative	T-90-N-CG	T-90-N-OP		
T-90-1	1 - 20c/mm	Positive				T-90-1-P-RM
T-90-2	1 - 100c/mm	Postive			T-90-2-P-TM	



Overall Size: 100mm x 100mm

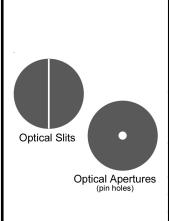
T-100

DIGITAL / ELECTRONIC PIXEL TARGET

Data: Range from 0.1 to 2.0mm in discrete steps of 2.0, 1.8, 1.6, 1.4, 1.2, 1.0, 0.9, 0.8, 0.7, 0.6, 0.5, 0.4, 0.3, 0.2 and 0.1 in vertical, horizontal and angled design.

Notes: Ideally suited to test sensor chip technology for minimum pixel sensing where dithering and cross linking can occur with other type of multi-cycle test targets.

Polarity Chrome on Glass **OPal** glass Trans. Material Refl. Material T-100 Positive T-100-P-CG T-100-P-TM T-100-P-OP T-100-P-RM



	OPTICA			OPTICAL APERTURES (Pin Holes)		
	Chrome on Glass	OPal glass	Size	Polarity	Chrome on Glass	OPal glass
	GS-10-N-CG	GS-10-N-OP	10.0μm	Negative	OA-10-N-CG	OA-10-N-OP
	GS-25-N-CG	GS-25-N-OP	25.0µm	Negative	OA-25-N-CG	OA-25-N-OP
	GS-30-N-CG	GS-30-N-OP	30.0µm	Negative	OA-30-N-CG	OA-30-N-OP
	GS-50-N-CG	GS-50-N-OP	50.0μm	Negative	OA-50-N-CG	OA-50-N-OP
Optical Slits	GS-100-N-CG	GS-100-N-OP	100.0μm	Negative	OA-100-N-CG	OA-100-N-OP
	GS-200-N-CG	GS-200-N-OP	200.0μm	Negative	OA-200-N-CG	OA-200-N-OP
	GS-300-N-CG	GS-300-N-OP	300.0μm	Negative	OA-300-N-CG	OA-300-N-OP
Optical Apertures (pin holes)	GS-400-N-CG	GS-400-N-OP	400.0μm	Negative	OA-400-N-CG	OA-400-N-OP
	GS-500-N-CG	GS-500-N-OP	500.0μm	Negative	OA-500-N-CG	OA-500-N-OP
	GS-600-N-CG	GS-600-N-OP	600.0µm	Negative	OA-600-N-CG	OA-600-N-OP
Overall Size: 25.4mm diameter	GS-700-N-CG	GS-700-N-OP	700.0μm	Negative	OA-700-N-CG	OA-700-N-OP
Over an Size. 23.4mm diameter	GS-1000-N-CG	GS-1000-N-OP	1000.0μm	Negative	OA-1000-N-CG	OA-1000-N-OP

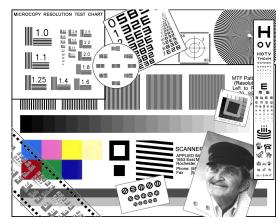
Quality Assurance

GRAPHIC / PHOTO / COPIER TEST ARRAYS

APPLIED IMAGE is an internationally renowned leader in the design and manufacturing of STANDARD and CUSTOMIZED Image Evaluation TEST TARGETS & IMAGE ANALYSIS STANDARDS.

With over twenty-five years of experience, APPLIED has the knowledge and expertise to fulfill today's complex and demanding requirements. It's no wonder that such a large and vast array of industries depend on APPLIED for their high quality test target and calibration solutions.

The combination of **APPLIED**'s advanced CAD design technology, unique semiconductor & electronic imaging systems, coupled with our clean room facilities and expert staff, guarantees that our manufacturing capabilities are second to none. The **APPLIED**'s quality control department assures the precision of every standard produced with the most advanced Q.C. measuring capabilities, all traceable to NIST.



No image is too small. No quantity is too large. No shape or size materia is too exotic. From start to finish. From a single piece prototype to high volume production components, the APPLIED staff is capable of fulfilling the most demanding specifications. So the next time you are searching for a high quality precision manufactured test target or image analysis calibration aid, think of APPLIED IMAGE.

§ E 8 **E E E**

Overall Size: 15.0" x 9.625" 381mm x 254 mm

QA-1

MOTION TARGET (Rotary)

Data: Image area 229mm x 356mm (9" x 14"); encompassing five NBS 1010A / ISO Test Chart #2 targets (see T-10); 3c/mm ladder charts; variety of type sizes and density patches; reduction scale.

Notes: Suited for evaluation of motion or rotary systems as in scanners, rotary micrographics or copiers where there is a synchronized motion component.

> Part No. QA-1-P-RM

Overall Size 254mm x 381mm

Material Reflective Material



Overall Size: 15.0" x 11.5' 381mm x 292 mm

QA-2

STATIC TARGET (Planetary)

Image area 280mm x 356mm (11" x 14"); outer array with 216mm x 280 mm (81/2" x 11") inner array; encompassing nine NBS 1010A / ISO Test Chart #2 targets (see T-10); variety of type sizes and distortion grids. 150mm and 6 inch reduction scales are included.

Notes: Useful for multi-evaluation of graphic or still camera imaging systems. Also available in a Metric version (QA-2M).

> Part No. OA-2-P-RM

Divisons (English) QA-2M-P-RM (Metric)

Overall Size 292mm x 381mm 305mm x 425mm

Material Reflective Material Reflective Material

QA-3

SMALL AREA TARGET (AIIM MS-303-1980)

Size 216mm x 280mm (81/2" x 11"); conforms to Navy specifications. Five NBS 1010A / ISO Test Chart #2 targets (see T-10) radially positioned; includes reduction scale of 150mm and 6 inch.

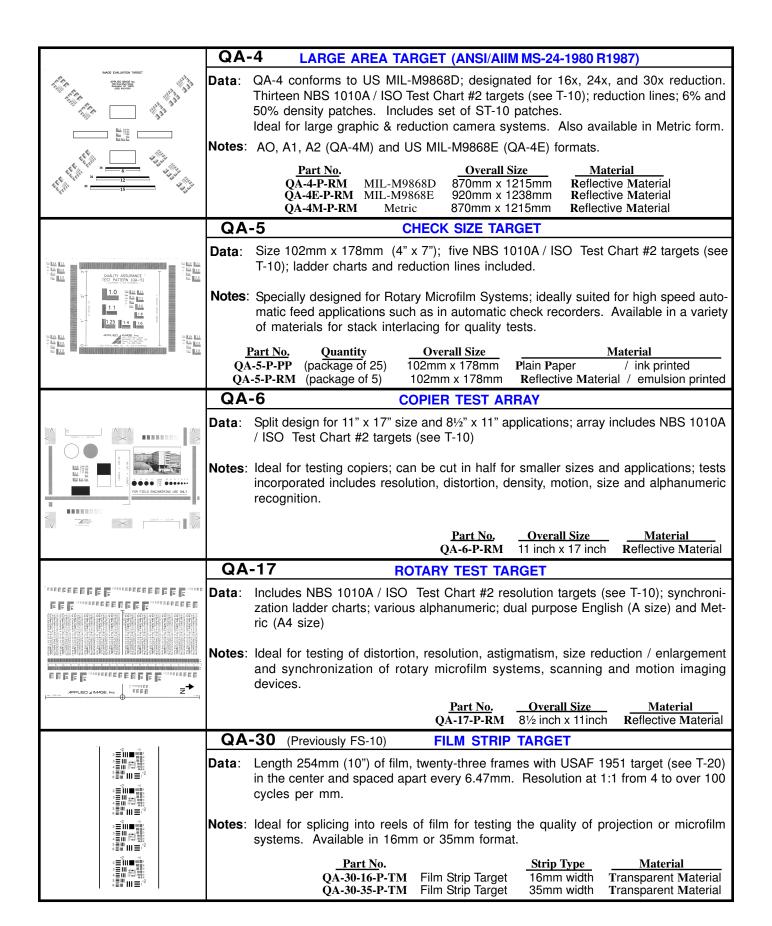
Notes: Ideal for evaluation of Optical / Mechanical Systems; where reduction and low resolution is of interest.

> Part No. A-3-P-RM

Overall Size 216mm x 280mm Material



Reflective Material



Quality Assurance

DIGITAL / VIDEO / CAMERA TEST ARRAYS



QA-60

COPIER / SCANNER DIGITAL TEST TARGET

Data: Eastman Kodak / Digital Science Imaging Test Chart (TL5003). Size 216mm x 279 mm (8½" x 11"); 15 grey patches; 5 Ronchi patterns (30, 50, 75, 100, 150 cycles per inch); text (2 to 12 point); half tone screen dots (65 and 120 per inch); star pattern (50, 100 & 200 lines per inch); resolution chart (1.5 to 18 c/mm) and 16 combinations of multi-density text

> Part No. **OA-60-TL5003-P-RP** 216mm x 279mm

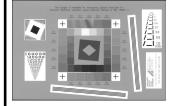
Overall Size

Material

RP - photo paper

QA-61

REFLECTIVE SCANNER TEST CHART (ISO-16067-1)



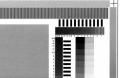
Data: Size 100mm x 152mm (4" x 6"); Designed to ISO-16067-1 specifications. Includes Landolt Ring, alphanumeric resolution and slant edge charts; grey step patches, horizontal, vertical and slanted ronchi patterns (6 to 40 c/mm) plus the APPLIED T-100 Digital Electronic Pixel target.

Notes: Used for determining reflective light resolution & imaging characteristics of digital scanning systems.

Part No. OA-61-ISO-16067-1-P-RP **Overall Size**

Material

152mm x 152mm RP - photo paper



QA-74

FBI SIQT SCANNER TEST CHART

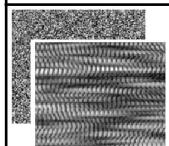
Data: The FBI designed this chart for gray level and resolution testing of the new Integrated Automated Fingerprint Identification System (IAFIS). The chart includes Ronchi areas with frequencies from 1 c/mm to 19.6 c/mm and uniform gray areas having consistency better than ± 0.02 OD.

Notes: See SINE M-13-60-1x and SINE M-15-60 FBI standards for fingerprint scanners

Part No. **OA-74-P-RM**

Overall Size 200mm x 125mm

Material Reflective Material



QA-80 & QA-81

RANDOM TEST PATTERN

Data: QA-80 The Imaged Random Test Pattern is a reflective target, which is imaged onto a detector array. This pattern is a 15.2 cm square image on semi-matte photographic paper. Its power spectral density (PSD) is 'white' and has equal power at all spatial frequencies.

Notes: QA-81 In applications where the MTF of the detector array alone is required, the Projected Random Test Pattern can be projected directly onto the the detector Part No. Image Size Material array.

OA-80-P-RM

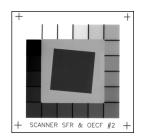
152mm x 152mm

Reflective Material

Transparent Material

QA-81-P-TM

28mm x 35mm



QA-62

SLANT EDGE TARGET

Data: Size 75mm x 75mm (3" x 3"); 25mm dark grey square rotated (5 degree) on a light grey background; surrounded by 20 - 9mm square grey scale patches.

Notes: Ideal for evaluation response of digital systems to the slanted sharp edge function and used for MTF analysis.

Part No.

Overall Size

Material

QA-62-SFR-P-RP

95mm x 76mm

RP - photo paper

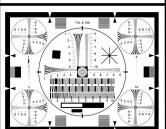
8 COLORS TARGET

PICTURE / CHECK SIZE SCANNER COLOR TARGET **QA-69**

Data: Size 110mm x 190mm (41/4" x 71/2"); five MTF patterns (30, 70, 95, 140, & 180 Line Pairs Per Inch); 20 density step wedge; various alphanumerics, two density strips, 8 color patches, 5.71 degrees (10:1 ratio) angle ronchi ruling.

Notes: Ideal for evaluation of color flatbed scanners and digital imaging devices.

Overall Size Part No. Material 110mm x 190mm QA-69-P-RM Reflective Material



QA-71

IEEE VIDEO RESOLUTION CHART

Data: The IEEE Video Resolution Chart conforms to standard STD 208-1995, "Measurement of Resolution of Camera Systems". This standard is used to test frequency response, characteristics performance of the lens, camera and display device. It replaces the EIA Resolution Chart. Image area: 203mm x 152mm.

> **Overall Size** Part No. Material OA-71-P-RM 229mm x 184mm Reflective Material

QA-76

DIGITAL CINE RESOLUTION CHART

Data: Digital CINE Camera Resolution Chart is an adaptation of the features of the "ISO12233" standard (QA-72)", to higher aspect ratios and also include new higher resolution features. This target's active area measures 60cm x 144cm.

> Material Part No. Active Size **OA-76-P-RM** 600mm x 1440mm Reflective Material

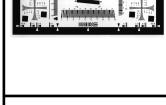


QA-72 DIGITAL STILL CAMERA RESOLUTION CHART / ISO-12233

Data: Includes 100 -1000 Line Width / Pixel Height; checker pattern; multiple lightly slanted square, lines; and other geometries; framing 1:1, 4:3, 3:2, and 16:9 aspect ratios: Center focus zone plate; 100 - 600 LW/PH and 500 - 2000

LW/PH hyperbolic wedges.

Active Size Material Part No. Chrome on Glass QA-72-1-P-CG 20mm x 36mm OPal glass 20mm x 36mm QA-72-1-P-OP Chrome on Glass **QA-72-2-P-CG** 100mm x 178mm OPal glass **QA-72-2-P-OG** 100mm x 178mm Reflective Material **OA-72-2-P-RM** 100mm x 178mm Reflective Material QA-72-P-RM 200mm x 356mm Reflective Material QA-72-3-P-RM 400mm x 711mm Reflective Material **OA-72-4-P-RM** 800mm x 1422mm



QA-77

ENHANCED DIGITAL CAMERA RESOLUTION CHART

Data: Based on ISO-12233, the QA-77 has all of the original features as the QA-72 plus several new ones, such as; Star Sector target; 5 degree slant bar; 5 degree dark Material

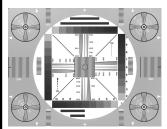
gray square for SFR analysis as well as a greater resolution range. from 100-4000 Line

Part No. **Active Size** 200mm x 356mm OA-77-P-RM OA-77-3-P-RM 400mm x 711mm OA-77-4-P-RM* 800mm x 1422mm Reflective Material

Reflective Material Reflective Material

Width / Pixel Height.

(* QA-77-4-P-RM will not contain gray features - black line only)



QA-70 (Previously QA-7)

VIDEO RESOLUTION PATTERN

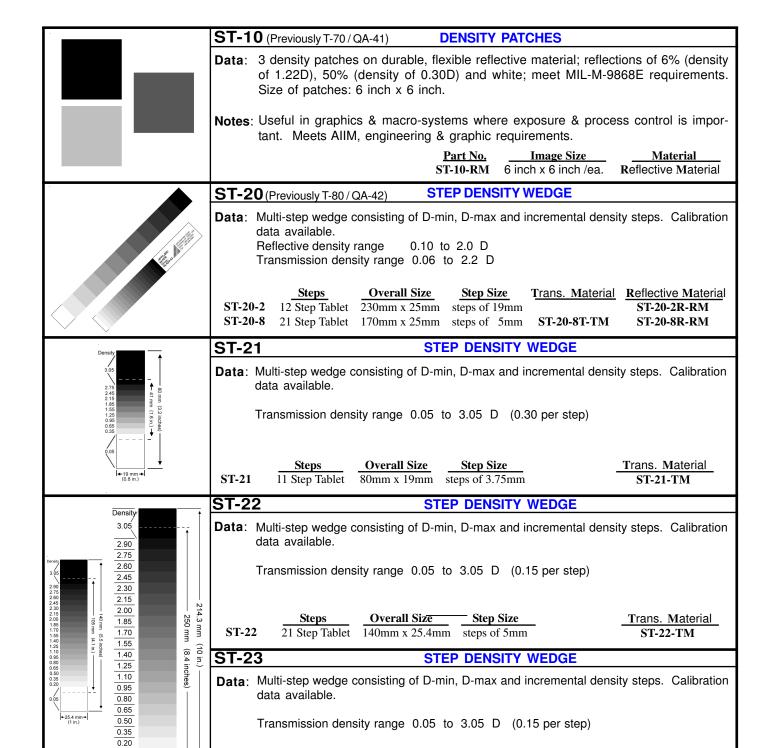
Data: Based on EIA 1956 chart. Includes linear and pie shapes from 200 to 1000 lines, 10 step density tables, measurement bars and edge definition points.

Notes: Measurements of Tele-cine cameras for streaking, ringing, aspect ratio; scan linearity and other video and cine systems. Available in other custom sizes on request.

Part No.	Overall Size	Material	
QA-70-1-P-RM	228mm x 305mm (9" x 12")	Reflective Material	
QA-70-1-P-TM	208mm x 305mm (9" x 12")	Transparent Material	
QA-70-2-P-CG	50mm x 50mm (2" x 2")	Chrome on Glass	
OA-70-2-P-OP	50mm x 50mm (2" x 2")	OPal glass	

Step Tablets

GRAY SCALES - DENSITY REFERENCE CHARTS



Overall Size

250mm x 35mm

ST-23

21 Step Tablet

0.05

+ 35 mm (1.4 in.) Step Size

steps of 11.9mm

Trans. Material

ST-23-TM

0.70 0.10 0.15 0.20 0.25 0.30 0.35 0.40 0.70 0.46 0.50 0.55 0.60 0.66 0.70 0.75 0.80 0.85 0.90 0.95 1.00 1.05 1.10 1.15 1.20 1.25 1.30 0.70 1.35 1.40 1.45 1.50 1.55 1.60 0.10 0.70

ST-50

REFLECTION GRAY CHART

Data: The ST-50 gray scale chart is a reflection object on semi-matte photographic paper. It is available either calibrated or uncalibrated. The four corner patches for the calibrated scales are within 0.02 density of each other. Each area is 10mm square.

Part No. ST-50-RM Overall Size 40mm x 90mm

Material
Reflective Material



ST-51

EIA HALFTONE GRAY SCALE

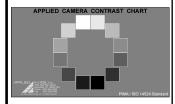
Data: The EIA grayscale pattern is a standard 2" square projection slide. It contains two parallel gray scales. The upper scale has nine nominally equal transmission steps while the lower contains the same number of nominally equal density steps. The transmission values range from 3% to 60%, corresponding to density values of 1.52 and 0.22 respectively. The slide is chrome on glass and densities are achieved by a fine halftone pattern.

Part No. ST-51-CG Overall Size 2 inch x 2 inch

Material Chrome on Glass

ST-52

ISO DIGITAL CAMERA CONTRAST CHART



Data: This Camera Contrast Chart conforms to International Standard ISO 14524, "Photography - Electronic Still Picture Cameras - Methods for Measuring Opto-Electronic Conversion Functions (OECF's)".

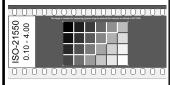
Notes: Chart area measures 356mm x 200mm with 12 gray levels on a durable material. Density range from 0.10 to 2.30.

Part No. ST-52-RM Overall Size 356mm x 200mm

Material
Reflective Material

ST-53

ISO 21550 DYNAMIC RANGE FILM TARGET



Data: This target conforms to International Standard ISO 21550, "Electronic Scanners for Photographic Images - Dynamic Range Measurement". The ST-53 is available in two different target configurations; ST-53-1-TM has 0.1 to 4.0 Optical Densities which are appropriate for imaging media associated with direct visual viewing situations such as photographic slides or paper prints; and ST-53-2-TM has 0 to 6.0 Optical Densities which are appropriate for intermediate imaging media such as negatives.

<u>Part No.</u> ST-53-1-ISO-21550-N-TM Overall Size
35mm x 85mm

Material
Trans. Material

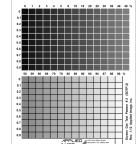
ST-53-2-ISO-21550-N-TM

35mm x 85mm

Trans. Material

SDTP-2

P-2 SCREEN DOT TEST PATTERN



Data: Ideally useful for very fine incremental testing the effects of very small feature size and area changes.

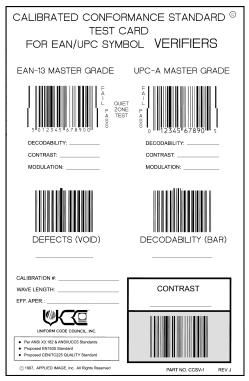
Notes: The image consists of 301 patches, in a grid layout, approx. 71mm (w) by 83mm (h) with each patch being approx. 4.7mm (w) by 4.0mm (h). Selected ranges of screen dot percentage patterns are provided in increments of 0.1%; and the ranges presented are; 0.0-5.9%; 9.0-10.9%; 19.0-20.9%; 29.0-30.9%; 39.0-40.9%; 49.0-50.9%; 59.0-60.9%; 69.0-70.9%; 79.0-80.9%; 89.0-90.9%; and 95.0-100%.

Part No. Overall Size Material
SDTP-2-N-RM 127mm x 127mm Reflective Material
SDTP-2-N-TM 127mm x 127mm Trans. Material
SDTP-2-P-CG 127mm x 127mm Chrome Glass

Bar Code

CALIBRATION CONFORMANCE STANDARDS

In 1989, ANSI established a Bar Code Print Quality program creating a relative scale for bar code print quality levels which is now known as ANSI X3.182 methodology. As an adjunct to the ANSI standard, **APPLIED IMAGE** in conjunction with UCC and AIM, developed a unique set of bar code calibration standards, which are based on the ANSI X3.182 & ANSI/ UCC5 standards and the proposed EN 1635 and CEN/TC225 Quality standards. The production of the bar code standards is monitored using a specialized, custom-built scanning microdensitometer, "The Judge", which has been calibrated to ANSI methodology and is traceable to NIST.



UCC/EAN Calibrated CONFORMANCE Standard

Part No. CCSV-1

This special UCC/EAN Calibrated Conformance Standard chart has been designed in conjunction with the Uniform Code Council. The purpose of this chart is to provide the U.P.C. bar code industry with an accurate calibration tool in which a minimum performance level must be met. The chart is ideal for testing of verifiers, scanners, and other U.P.C. bar code reading equipment. In addition, this tool can also be used as a training mechanism for new operators to assure proper "methodology" in the use of verifiers. Each symbol comes complete with individually certified values.

UCC / EAN Primary CALIBRATION Standard Set

Part No. UPC-SET

The U.P.C. Verification Calibration Standard is a unique set of symbols that assures an exact and reliable primary bar code standard that exist for U.P.C. codes based on ANSI X3.182 methodology. The complete group of 32 Calibrated Bar Code Primary Standards assures that manufacturers of verification equipment, scanners, QC labs and the "need to know" users now have a basis for comparison reading performance of various equipment.

These standards are intended as a fundamental calibration set

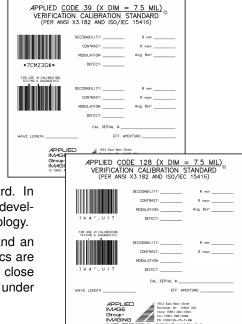
for any QC program, providing a continuous scale from "best" to "worse" case characteristics of each parameter with full traceable data. Ideally suited to those requiring traceability, such as ISO certification.

AIM Code 39 & Code 128 Verification CALIBRATION Standards

Part No. Code 39 Code 128

Until now, when verifying or scanning Code 39 or Code 128, there was no basis for system accuracy which assured that the system met the ANSI X3.182 standard. In cooperation with AIM, a unique group of Calibrated Bar Code Standards were developed which check the functionality of the systems based on the ANSI methodology.

Each test card has been designed to test at two levels (the highest A grade and an acceptable C performance grade). In addition, a full compliment of characteristics are checked for each symbol and reported. In this way one can check to see how close their device is functioning to a known standard. Each card is fully compatible under the guidelines of AIM - USA, as well as AIM - Europe.



Each standard is imaged on special high definition plastic polymer materials, laminated to minimize reflection changes and packaged in special storage boxes for protection. All calibration standards come complete with a Certificate of Compliance, traceability documentation and calibration data.

Cat No.

CCSV-1 UCC/EAN Calibrated CONFORMANCE Standard

One piece durable test chart having all test samples in a simple to use array. Each chart, designed to be fully applicable in both EAN or U.P.C. applications, has the following characteristics; perfect Grade A symbols (EAN-13 and UPC-A) with Quiet Zone Test Areas; three Grade C symbols that test for Defects (Voids), Decodability (Bar) and Contrast. All symbols are 100% size; U.P.C./EAN. Each chart comes with NIST traceable calibration.

UPC-SET UCC/EAN Primary CALIBRATION Standard Set

Complete group of 32 bar code calibration standards, master perfect to system and step reflective chart. All calibration bar code standards are fully compatible with U.P.C. and EAN bar codes. All symbols are 100% size; U.P.C./EAN. Each chart comes with NIST traceable calibration. (Custom Boxed Set)

UPC Primary - Individual Components

(Actual values are recorded on symbol and individually serialized)

Grade	Symbol Contrast Cat no.	Modulation Cat no.	Defect Spots Cat no.	Defect Voids Cat no.
Grade A Grade B Grade C Grade D Grade F UPC Number	UPC-CONT-A UPC-CONT-B UPC-CONT-C UPC-CONT-D UPC-CONT-F 0 1234567890 5	UPC-MODU-A UPC-MODU-B UPC-MODU-C UPC-MODU-D UPC-MODU-F 0 00000 41000 7	UPC-SPOT-A UPC-SPOT-B UPC-SPOT-C UPC-SPOT-D UPC-SPOT-F 0 00006 30000 5	UPC-VOID-A UPC-VOID-B UPC-VOID-C UPC-VOID-D UPC-VOID-F 0 00006 30000 5
			Cat no. UPC-MAST-R Master Perfect to System Reflection Standard	
Grade	Decodability Edge Cat no.	Decodability Bar Cat no.	Master Perfect	to System
Grade Grade A Grade B	_	•	Master Perfect	to System Standard

Individual Symbol Contrast, Modulation, Defect Spots, Defect Voids, Decodability Edge, Decodability Bar, Master Perfect to System Reflection Standard and the 6-Step Reflective Chart can be purchased separately.

CODE-39	AIM Code 39 Verification CALIBRATION Standard - Set of two charts (X DIM = 4.4 MILS and X DIM = 7.5 MILS) Grade A plus Grade C test symbols which check for contrast, decodability, modulation and defects. This standard comes with NIST traceable calibration.
CODE-128	AIM Code 128 Verification CALIBRATION Standard - Set of two charts (X DIM = 4.4 MILS and X DIM = 7.5 MILS) Grade A Plus Grade C test symbols which check for contrast, decodability, modulation and defects. This standard comes with NIST traceable calibration.

APPLIED IMAGE, a worldwide leader in the **PHOTONICS** industry, offers a wide array of standard off- the-shelf products as well as **high quality custom manufacturing capabilities** for your every need. **TARGETS, SCALES, RETICLES, ROBOTIC VISION, MASKS, IMAGING CALIBRATION STANDARDS, BAR CODE Symbols**, and **ENCODERS**. Our experienced technical staff is ready to assist you in your next project, or on your existing products using your exact specifications; from initial design engineering, through prototyping and into final manufacturing.

Let **APPLIED IMAGE Group** help put **PHOTONICS IMAGING** to work for you!

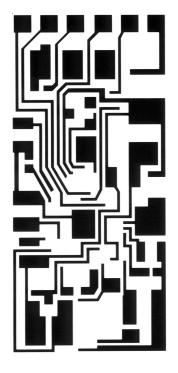


Mask Making

SERVICES

IC MCM HYBRIDS

Thin and thick film masks and screens can be accommodated in all substrates and sizes to meet your requirements. Work can be performed from your data base or our expert CAD group would be pleased to layout the design for you.



ACCURATE PHOTOTOOLS

For a quarter of a century, **APPLIED IMAGE** has been serving the needs of the imaging industry with precision masks, reticles, test targets and phototools of the highest quality. Our thorough knowledge of **HYBRIDS** (both thin and thick film), microwaves, large displays, surface mounted technology and encoders assures that our customers will receive the quality product they expect, on time and at a reasonable price.

APPLIED's unique state-of-art equipment, facilities and professional staff provides a wide variety of solutions for today's mask needs. **APPLIED** is truly a "one step" imaging center where the solutions to your needs are our expertise.

MICROWAVE | GUIDE

Designing and imaging microwaves can be tricky, but our wide assortment of equipment and facilities assures meeting even the most stringent government specifications.



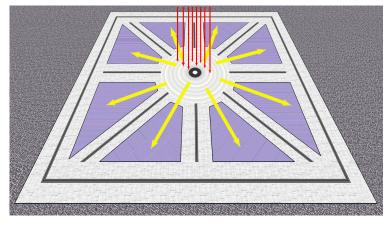
COMPLETE SOLUTIONS

The first step in making the mask is the design. **APPLIED** starts with your CAD data or, if you prefer, our extensive CAD department will design the layout for you.

After appropriate checks, the output is then routed to either our micro or macro group, depending on your particular needs. The micro group pattern generates, step and repeats, and duplicates the masks to the highest standards. Or the macro group might photoplot, rubulith cut, camera reduce, step and repeat, duplicate or make screens as your needs require.

♦ SUBSTRATE FLEXIBILITY

A wide variety of masks, film tools and screens are available with formats up to 8 inch \times 10 inch for hybrids and semiconductors as large as 25 inch \times 30 inch for special applications (such as displays or thick films). The choice of substrates include emulsion, chrome, see-thru chrome, iron oxide on a sodalime glass base, low expansion quartz, or other specialty glass based materials. Or perhaps your requirements are for film tools, screens or even sandwiched hinged glass phototools all of which **APPLIED IMAGE** can provide.



♦ QUALITY

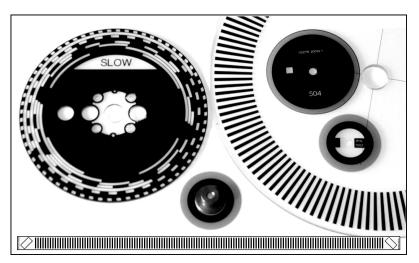
The single most important commodity is quality. This process starts with the review of the job when it first comes in. It is then carried through to check plot procedures established by our CAD group with our customers. Further, this same attention is carried through in process QC checks.

Finally, all jobs go through our final QC department. All QC checks are performed in stringent environmentally controlled and class 100 clean room facilities assuring you the highest quality.

ONE LAST WORD

If you need maks and designs for a hybrid, microwave, encoder, flat panel display, surface mounted devices or other specialized imaging needs, give us a call. We are ready to serve your needs.

DATA OPTICS, INC. Encoder Scales ROTARY and LINEAR



- LINEAR SCALES
- + ROTARY DISCS
- + TIMING ENCODERS
- GRAY ENCODER CODES
- MEASUREMENT SCALES

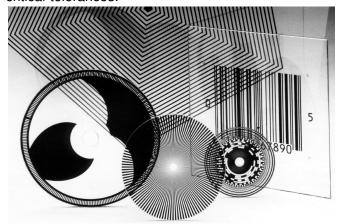
With 25 years of experience producing ENCODER strips, discs, scales and gray codes, the **APPLIED IMAGE** has become one of the foremost leaders in the art & science of producing such tight toleranced components.

APPLIED IMAGE offers custom and standard encoder discs and linear scales to meet your most demanding applications. With the accuracy of our equipment, traceable to the National Institute of Standards and Technology, we can custom design with guaranteed adherence to critical tolerances.

APPLIED will assist in identifying cost effective options for selecting the right material substrate in developing your encoder. Available materials include: photo emulsions on film; glass or plastics.

Chromium, aluminum, gold and inconel on glass as well as beryllium, copper, nickel electroform and other sophisticated metals.

Our reputation for technical expertise in the fields of imaging science and micro-imaging affords you the right combination necessary for accomplishing even the most difficult of designs.



Whether your needs is in printers and scanners, machine tools, robotics, industrial or military applications select **APPLIED IMAGE**, leaders in micro-imaging technology, to provide for those needs ... on time & within budget.

PARTS AVAILABLE FOR

Brother Dell Lexmark
Buehler Encad Samsung
Cephid Espon TRW
Compaq Hewlett Packard U-Max
Canon Kodak Xerox

Standard Reticles

GRATICULES

The **APPLIED IMAGE** has abeen manufacturing high quality STANDARD RETICLES for over two decades. <u>Call **APPLIED**</u> **IMAGE** to find out what design styles and sizes are availabile on specific reticles.

SIMPLE and DASHED CROSSHAIRS



Simple Cross Hair, 9µm wide 19mm dia. PART No. RET 42-19 RET 42-21 21mm dia. Simple Cross Hair, 17µm wide PART No. RET 41-19 19mm dia. RET 41-21 21mm dia. Simple Cross Hair, 25µm wide 19mm dia. PART No. **RET 43-19 RET 43-21** 21mm dia. Simple Cross Hair, 44µm wide PART No. **RET 40-19** 19mm dia. 21mm dia. **RET 40-21**

Dashed Cross Hair, 13µm wide PART No. RET 50-19 19mm dia. RET 50-21 21mm dia. Dashed Cross Hair, 63µm wide w/spurs 19mm dia. PART No. RET 51-19 21mm dia. RET 51-21 OffSet Dashed Cross Hair, 63µm wide 19mm dia. PART No. **RET 54-19** RET 54-21 21mm dia.

PARALLEL CROSSLINES



Parallel Cross Lines 0.025mm gap PART No. RET 60-19 19mm dia. 21mm dia. **RET 60-21** Parallel Cross Lines 0.075mm gap PART No. RET 61-19 19mm dia. RET 61-21 21mm dia. Parallel Cross Lines 0.125mm gap 19mm dia. PART No. RET 62-19 **RET 62-21** 21mm dia. Parallel Cross Lines 0.500mm gap PART No. RET 63-19 19mm dia. **RET 63-21** 21mm dia. Parallel Cross Lines 1.00mm gap PART No. RET 64-19 19mm dia. **RET 64-21** 21mm dia. Parallel Cross Lines 2.00mm gap PART No. RET 65-19 19mm dia. RET 65-21 21mm dia.

CROSSHAIR W/SCALES



CrossHair w/scale 20mm, div. of 0.10mm PART No. RET 21-19 19mm dia. RET 21-21 21mm dia.

SCALES



Scale 2mm long, 200 div. of 0.01mm PART No. RET 14-19 19mm dia. RET 14-21 21mm dia. Scale 5mm long, 50 div. of 0.1mm 19mm dia. PART No. RET 15-19 RET 15-21 21mm dia. Scale 5mm long, 100 div. of 0.05mm PART No. RET 11-19 19mm dia. RET 11-21 21mm dia. Scale 10mm long, 100 div. of 0.10mm PART No. RET 10-19 19mm dia. RET 10-21 21mm dia. Scale 10mm long, 200 div. of 0.05mm PART No. 19mm dia. RET 16-19 RET 16-21 21mm dia. Scale 15mm long, 150 div. of 0.10mm PART No. RET 13-19 19mm dia. RET 13-21 21mm dia. Scale 20mm long, 200 div. of 0.10mm PART No. RET 12-19 19mm dia. RET 12-21 21mm dia.

CROSSED SCALES



 PART No.
 RET 30-19
 19mm dia.

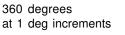
 RET 30-21
 21mm dia.

 Cross Scale
 20mm long, 200 div. of 0.10mm

Cross Scale 10mm, 100 div. of 0.10mm

20mm long, 200 div. of 0.10mm <u>PART No.</u> RET 32-19 19mm dia. RET 32-21 21mm dia.

PROTRACTOR



<u>PART No.</u> RET 94-19 19mm dia. RET 94-21 21mm dia.

SIMPLE GRIDS and LABELED GRIDS



Grid 5mm x 5mm x 0.5mm w/0.025mm line PART No. RET71-19 19mm dia. RET71-21 21mm dia. Grid 10mm x 10mm x 1mm w/0.025mm line PART No. RET73-19 19mm dia. RET73-21 21mm dia. Grid 5mm x 5mm x 1mm w/0.025mm line 19mm dia. PART No. RET70-19 RET70-21 21mm dia. Grid 10mm x 10mm x 0.5mm w/0.025mm PART No. RET74-19 19mm dia. 21mm dia. RET74-21

Labeled Grid 5mm x 5mm x 1mm w/0.01mm line - 1-5 horiz. / 1-5 vert, PART No. 19mm dia. **RET 83-19 RET 83-21** 21mm dia. Labeled Grid 10mm x 10mm x 1mm w/0.01mm line - 1-10 horiz. / A-J vert, PART No. **RET 81-19** 19mm dia. RET 81-21 21mm dia. Labeled Grid 10mm x 10mm x 0.50mm w/0.025mm line - 1-10 horiz. / 1-10 vert. **RET 80-19** 19mm dia. PART No. **RET 80-21** 21mm dia.

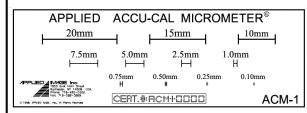
CONCENTRIC CIRCLES w/ CROSSHAIRS



10 Concentric Circles 0-5mm dia., 0.5mm div PART No. RET 92-19 19mm dia. RET 92-21 21mm dia.

10 Concentric Circles 0-10mm dia., 1.0mm div PART No. RET 93-19 19mm dia. RET 93-21 21mm dia.

APPLIED ACCU-CAL™ CALIBRATING MICROMETER



Part No. ACM-1

The ideal standard for Accurate Calibration of any eyepiece, reticle, filar instrument, electronic imaging or optical tube system. With a full array of fixed calibra-

tion lengths for quick set up and ease of use. Calibration magnification range: from 1x to 1000x power, with bar lengths 20mm to 0.10mm.

Overall size: 1" x 3" / image: chrome on glass / positive image